

## Features

- V<sub>DS</sub> (V) = 40V
- R<sub>DS(ON)</sub> < 17mΩ (V<sub>GS</sub> = 10V)
- R<sub>DS(ON)</sub> < 21mΩ (V<sub>GS</sub> = 4.5V)

## Applications

- High Frequency Isolated DC-DC Converters with Synchronous Rectification for Telecom and Industrial Use
- High Frequency Buck Converters for Computer Processor Power
- Lead-Free

## Benefits

- Ultra-Low Gate Impedance
- Very Low R<sub>DS(on)</sub>
- Fully Characterized Avalanche Voltage and Current

## Absolute Maximum Ratings

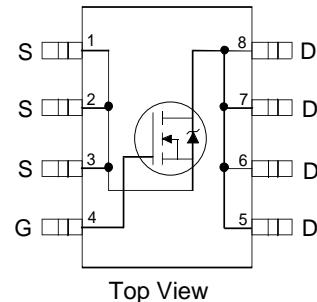
Symbol	Parameter	Max.	Units
V <sub>DS</sub>	Drain-Source Voltage	40	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	9.0	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	7.3	
I <sub>DM</sub>	Pulsed Drain Current①	73	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation③	2.5	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Maximum Power Dissipation③	1.6	W
	Linear Derating Factor	0.02	mW/°C
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to + 150	°C

## Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJL</sub>	Junction-to-Drain Lead		20	°C/W
R <sub>θJA</sub>	Junction-to-Ambient ④		50	

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting T<sub>J</sub> = 25°C, L = 8.1mH  
R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 7.2A.
- ③ Pulse width ≤ 400μs; duty cycle ≤ 2%.
- ④ When mounted on 1 inch square copper board.



Top View

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient		0.04		V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	12	17		$\text{m}\Omega$	$V_{GS} = 10V, I_D = 9.0\text{A}$ ③
			15.5	21		$V_{GS} = 4.5V, I_D = 7.2\text{A}$ ③
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current		20		$\mu\text{A}$	$V_{DS} = 32V, V_{GS} = 0V$
			100			$V_{DS} = 32V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage			200	$\text{nA}$	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage			-200		$V_{GS} = -16V$

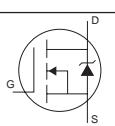
**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

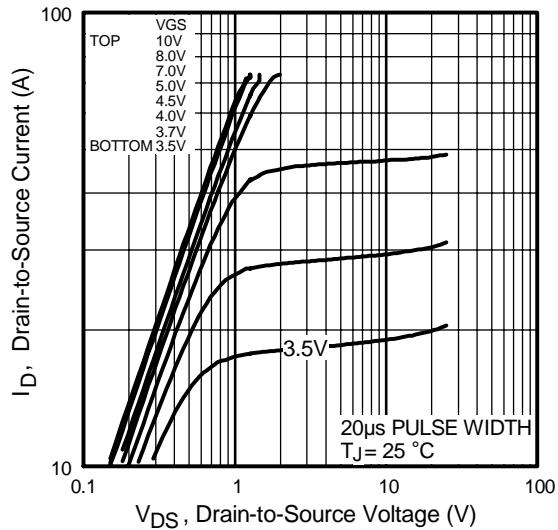
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{fs}$	Forward Transconductance	17			S	$V_{DS} = 20V, I_D = 7.2\text{A}$
$Q_g$	Total Gate Charge		15	23	nC	$I_D = 7.2\text{A}$
$Q_{gs}$	Gate-to-Source Charge		7.0	11		$V_{DS} = 20V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		5.0	8.0		$V_{GS} = 4.5V$ ③
$Q_{oss}$	Output Gate Charge		16	24		$V_{GS} = 0V, V_{DS} = 16V$
$t_{d(\text{on})}$	Turn-On Delay Time		11		ns	$V_{DD} = 20V$
$t_r$	Rise Time		2.2			$I_D = 7.2\text{A}$
$t_{d(\text{off})}$	Turn-Off Delay Time		14			$R_G = 1.8\Omega$
$t_f$	Fall Time		3.5			$V_{GS} = 4.5V$ ③
$C_{iss}$	Input Capacitance		2000		pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance		480			$V_{DS} = 20V$
$C_{rss}$	Reverse Transfer Capacitance		28			$f = 1.0\text{MHz}$

**Avalanche Characteristics**

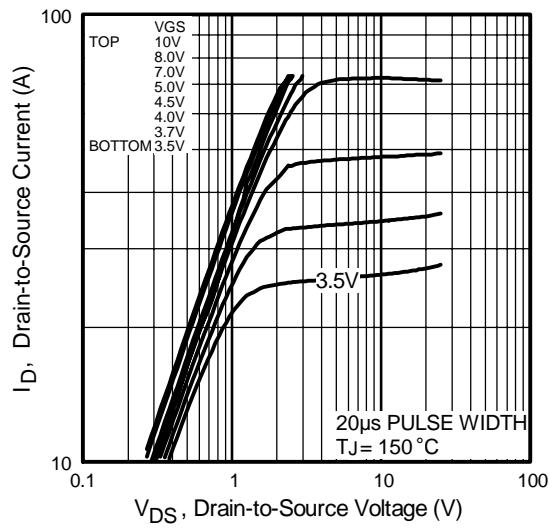
Symbol	Parameter	Typ.	Max.	Units
$E_{AS}$	Single Pulse Avalanche Energy ②		210	mJ
$I_{AR}$	Avalanche Current ①		7.2	A

**Diode Characteristics**

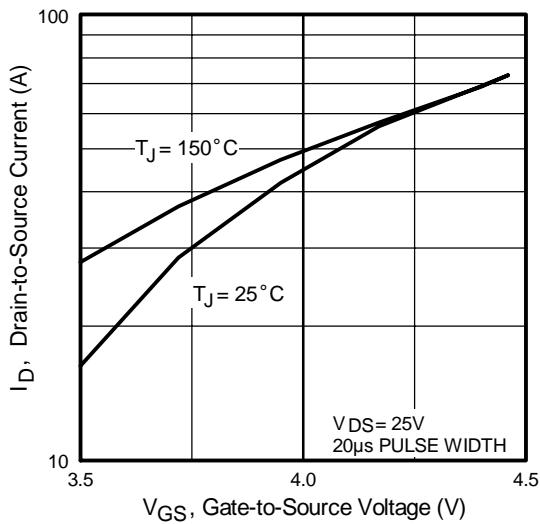
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current (Body Diode)			2.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①			73		
$V_{SD}$	Diode Forward Voltage	0.80	1.3		V	$T_J = 25^\circ\text{C}, I_S = 7.2\text{A}, V_{GS} = 0V$ ③
			0.65			$T_J = 125^\circ\text{C}, I_S = 7.2\text{A}, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	47	71	ns	nC	$T_J = 25^\circ\text{C}, I_F = 7.2\text{A}, V_R = 15V$ $dI/dt = 100\text{A}/\mu\text{s}$ ③
$Q_{rr}$	Reverse Recovery Charge	91	140			$T_J = 125^\circ\text{C}, I_F = 7.2\text{A}, V_R = 20V$ $dI/dt = 100\text{A}/\mu\text{s}$ ③
$t_{rr}$	Reverse Recovery Time	77	120	ns	nC	
$Q_{rr}$	Reverse Recovery Charge	150	230			



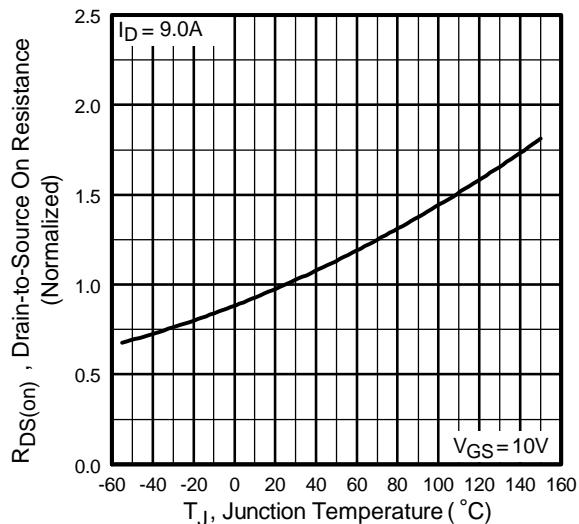
**Fig 1.** Typical Output Characteristics



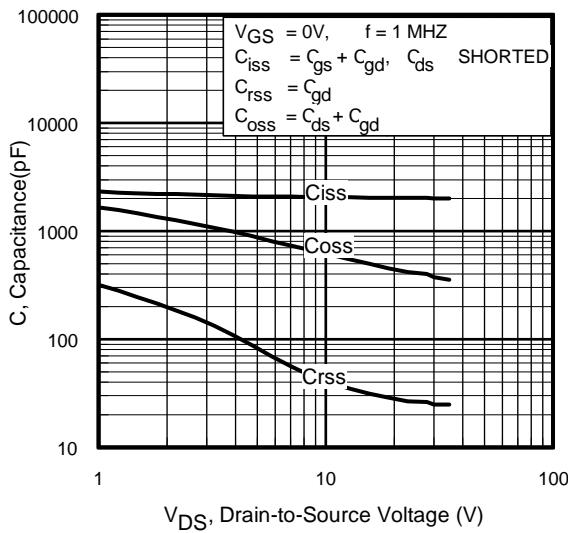
**Fig 2.** Typical Output Characteristics



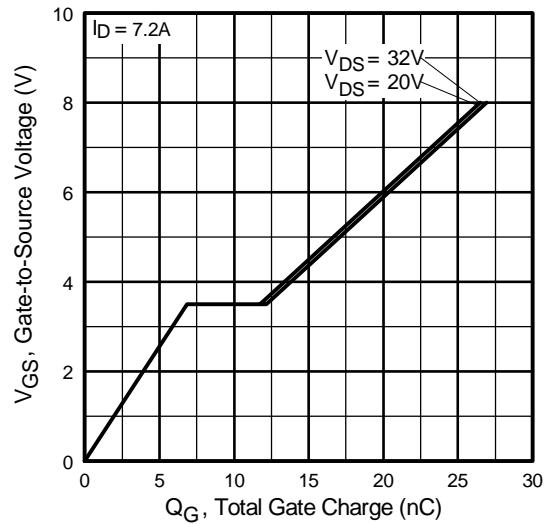
**Fig 3.** Typical Transfer Characteristics



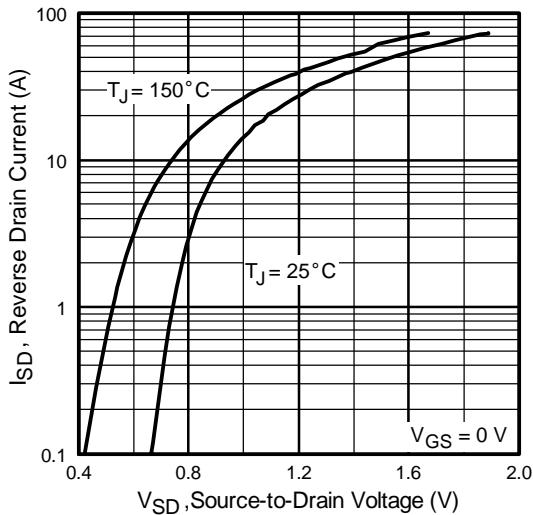
**Fig 4.** Normalized On-Resistance Vs. Temperature



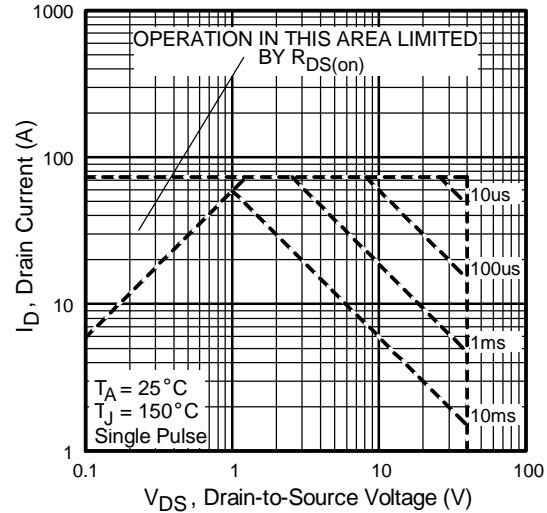
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



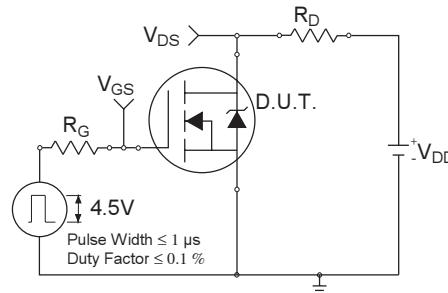
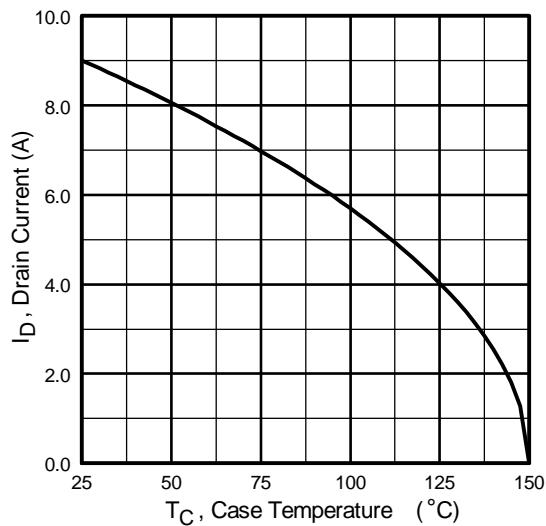
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



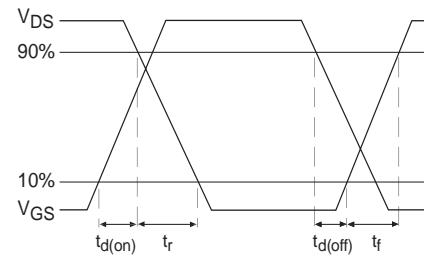
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



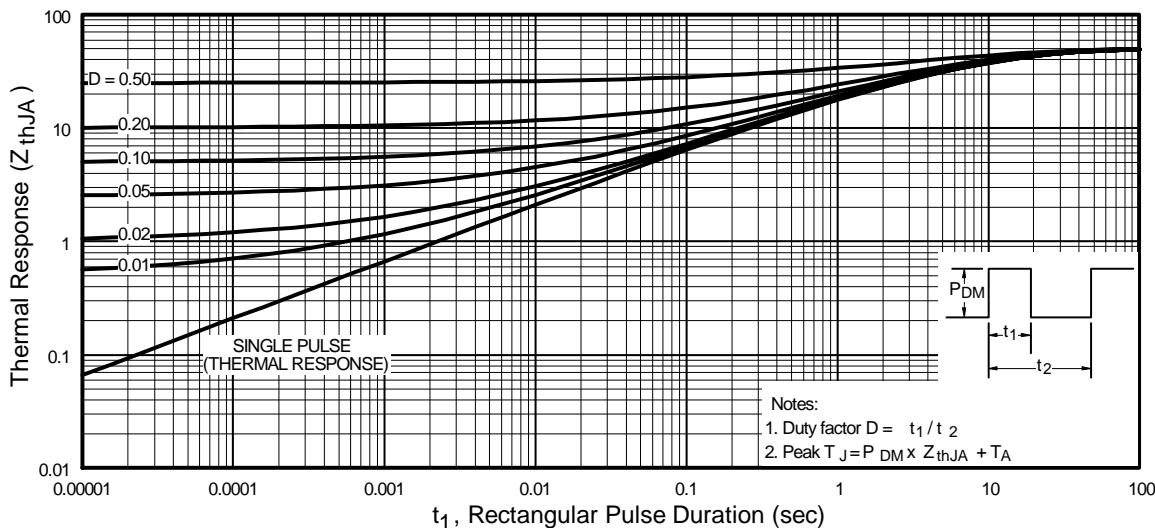
**Fig 8.** Maximum Safe Operating Area



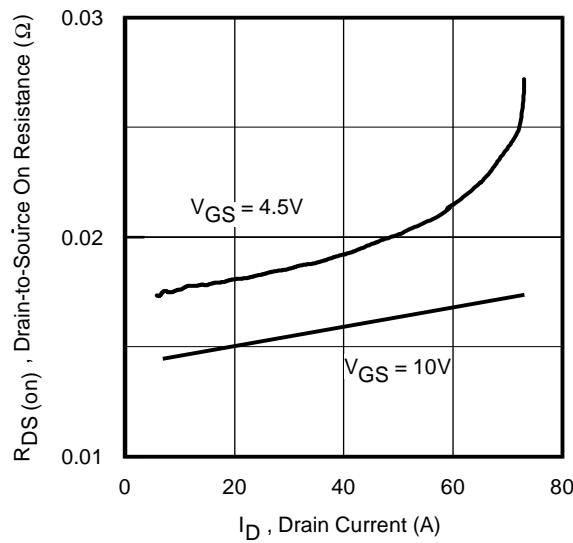
**Fig 10a.** Switching Time Test Circuit



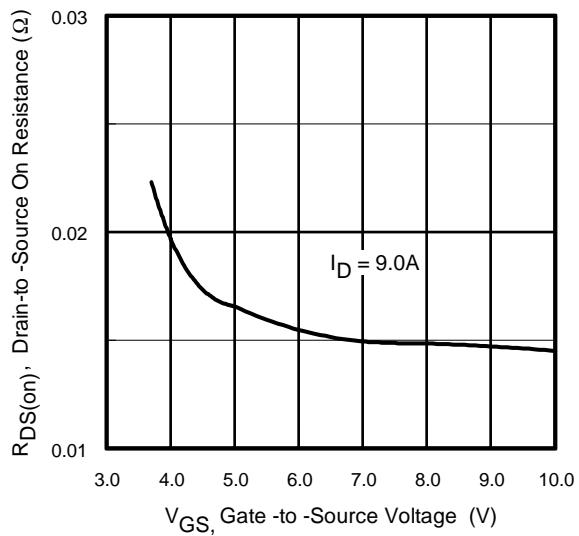
**Fig 10b.** Switching Time Waveforms



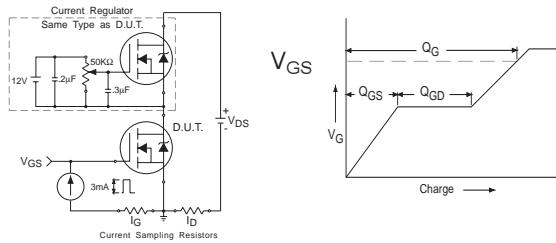
**Fig 10.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



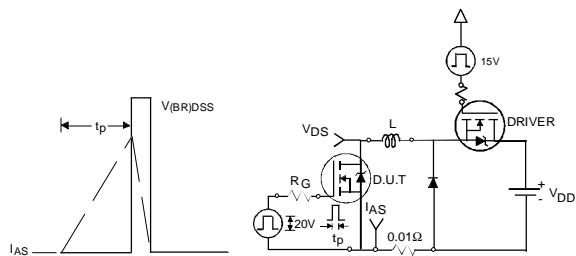
**Fig 12.** On-Resistance Vs. Drain Current



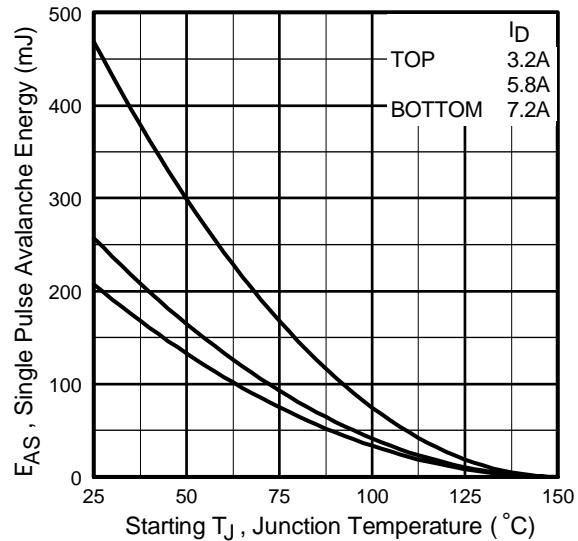
**Fig 13.** On-Resistance Vs. Gate Voltage



**Fig 13a&b.** Basic Gate Charge Test Circuit and Waveform

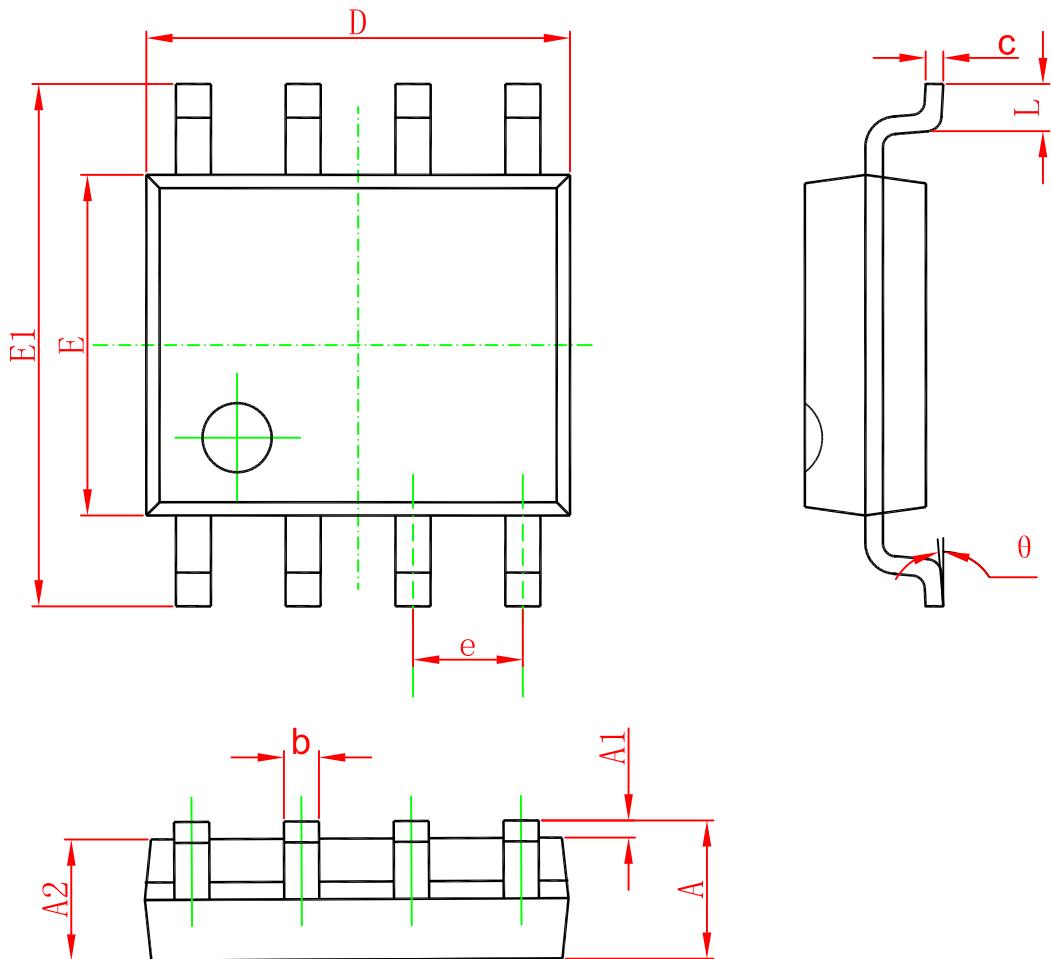


**Fig 14a&b.** Unclamped Inductive Test circuit and Waveforms



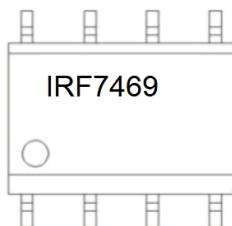
**Fig 14c.** Maximum Avalanche Energy Vs. Drain Current

**SOP-8**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
$\theta$	0°	8°	0°	8°

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
IRF7469TR	SOP-8	3000	Tape and reel